



WANSEMI
万芯半导体

WX028D03S6

Enhancement Mode N-Channel Power MOSFET

SOT23-6/NMOS/30V/±12V/0.95V/4A/28mΩ

Rev0.1

30V, 28mΩ, 4A, N-Channel MOSFET

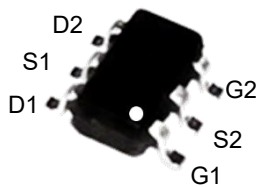
1.Features

- ◆ High Power and current handing capability
- ◆ Lead free product is acquired
- ◆ Surface Mount Package

V _{DS} Typ.	R _{DS(on)} Typ.	I _D Max.
30V	28mΩ @ 10V	4A
	31mΩ @ 4.5V	
	38mΩ @ 2.5V	

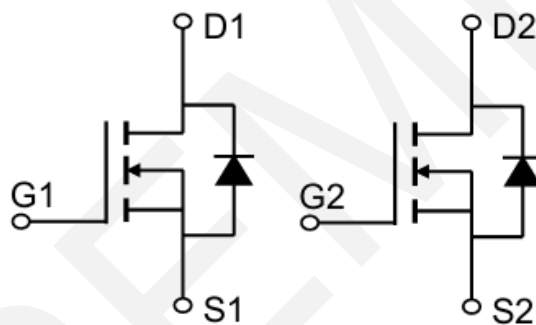
2.Applications

- ◆ Battery Protection
- ◆ Battery Powered Systems
- ◆ Power Management in Notebook Computer
- ◆ Portable Equipment



Pin Description

SOT23-6



Schematic Diagram

3.Package Marking and Ordering Information

Part no.	Marking	Package	PCS/Reel	PCS/CTN.
WX028D03S6	028D03	SOT23-6	3,000	180,000

4.Absolute Max Ratings at Ta=25°C (Note1)

Parameter	Symbol	Maximum	Units
Drain to Source Voltage	V _{DSS}	30	V
Gate to Source Voltage	V _{GSS}	±12	V
Drain Current-Continuous	I _D	4	A
Drain Current (Pulse)	I _{DM}	16	A
Maximum Power Dissipation	P _D	1.2	W
Junction Temperature	T _j	150	°C
Storage Temperature	T _{stg}	-55 to +150	°C

Note 1: Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

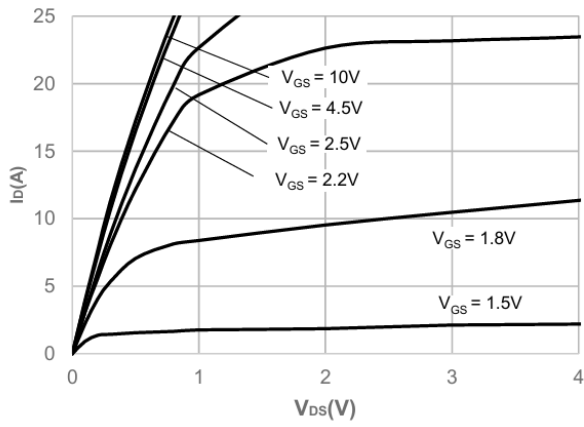
5. Electrical Characteristics at Ta=25°C (Note 2)

Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Units
Drain to Source Breakdown Voltage	$V_{(BR)DSS}$	$I_D = 250\mu A, V_{GS} = 0V$	30	-	-	V
Zero-Gate Voltage Drain Current	I_{DSS}	$V_{DS} = 30V, V_{GS} = 0V$	-	-	1	μA
Gate-Body Leakage Current	I_{GSS}	$V_{GS} = \pm 12V, V_{DS} = 0V$	-	-	± 100	nA
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_{DS} = 250\mu A$	0.6	0.95	1.3	V
Drain to Source On-State Resistance	$R_{DS(on)}$	$I_D = 4A, V_{GS} = 10V$	-	28	35	m Ω
		$I_D = 3A, V_{GS} = 4.5V$	-	31	38	m Ω
		$I_D = 3A, V_{GS} = 2.5V$	-	38	52	m Ω
Input Capacitance	C_{iss}	$V_{GS} = 0V,$	-	663	-	pF
Output Capacitance	C_{oss}	$V_{DS} = 15V,$	-	52	-	pF
Reverse Transfer Capacitance	C_{rss}	Frequency=1.0MHz	-	43	-	pF
Turn-ON Delay Time	$t_{d(on)}$	$V_{DD} = 15V, I_D = 3A,$ $V_{GS} = 4.5V, R_{GEN} = 3\Omega$	-	4	-	ns
Turn-ON Rise Time	t_r		-	17	-	ns
Turn-OFF Delay Time	$t_{d(off)}$		-	95	-	ns
Turn-ON Fall Time	t_f		-	37	-	ns
Total Gate Charge	Q_g		$V_{DS} = 15V,$	-	7	-
Gate-Source Charge	Q_{gs}	$V_{GS} = 0 \text{ to } 4.5V,$	-	1.7	-	nC
Gate-Drain Charge	Q_{gd}	$I_D = 3A$	-	1.6	-	nC
Diode Forward Voltage	V_{SD}	$I_S = 4A, V_{GS} = 0V$	0.5	-	1.2	V

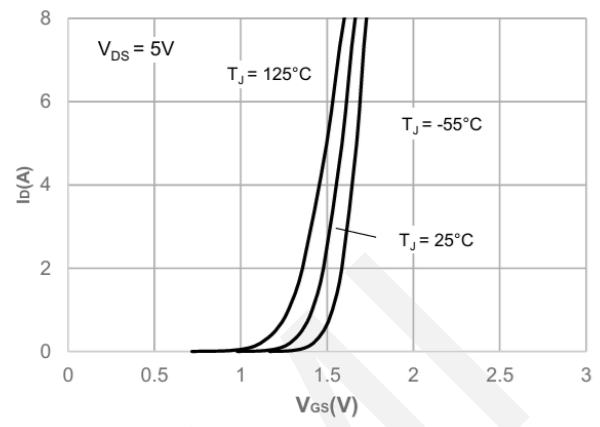
Note 2: Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.



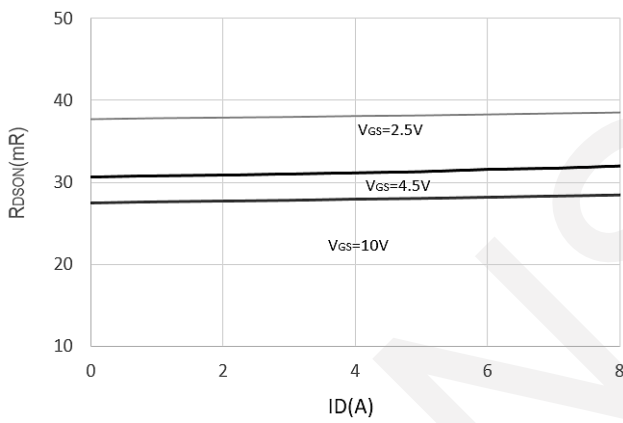
6. Typical electrical and thermal characteristics



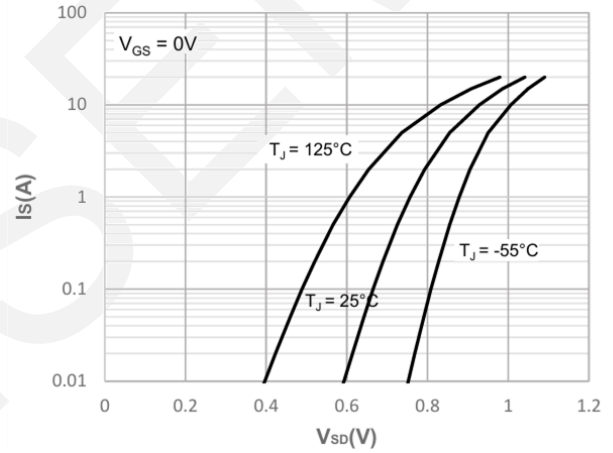
Output Characteristics



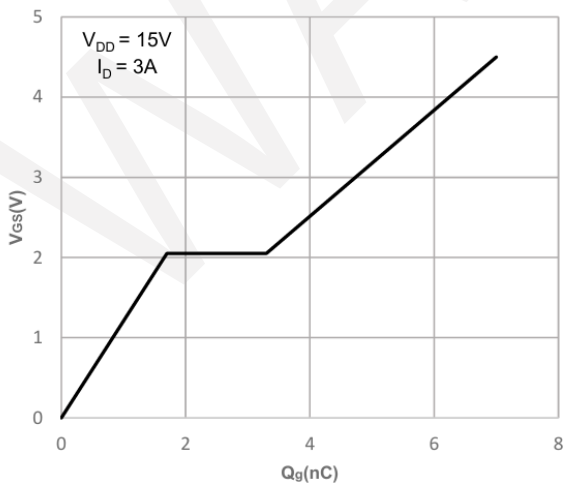
Typical Transfer Characteristics



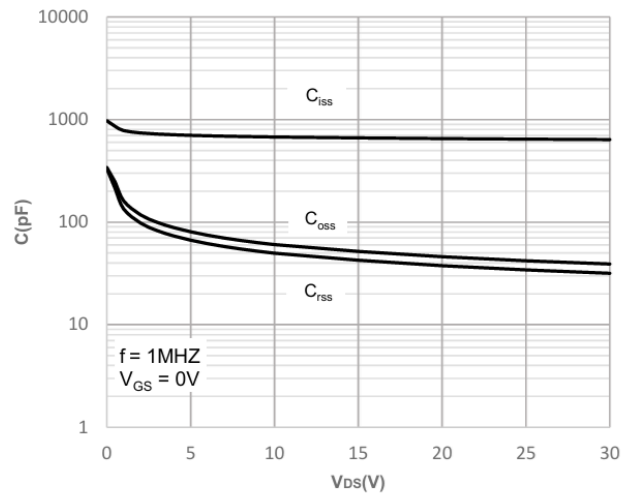
On-resistance vs. Drain Current



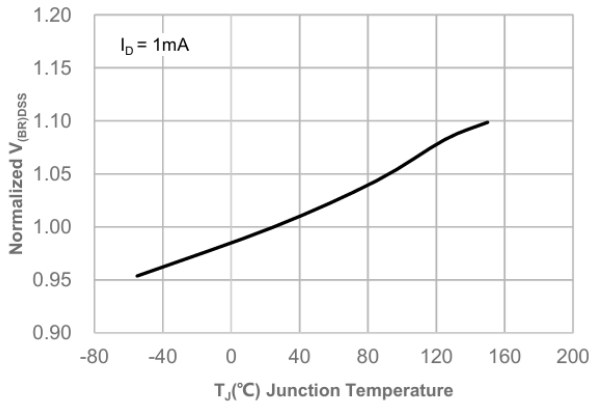
Body Diode Characteristics



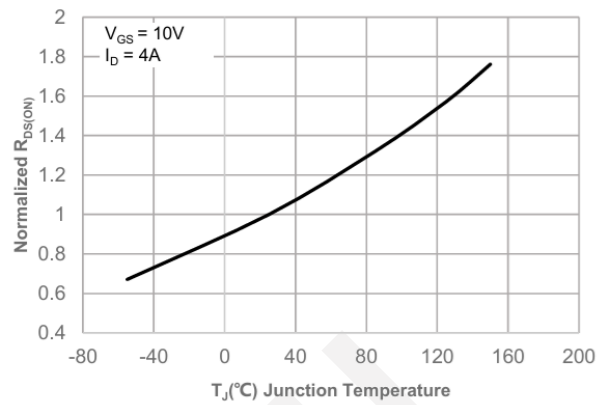
Gate Charge Characteristics



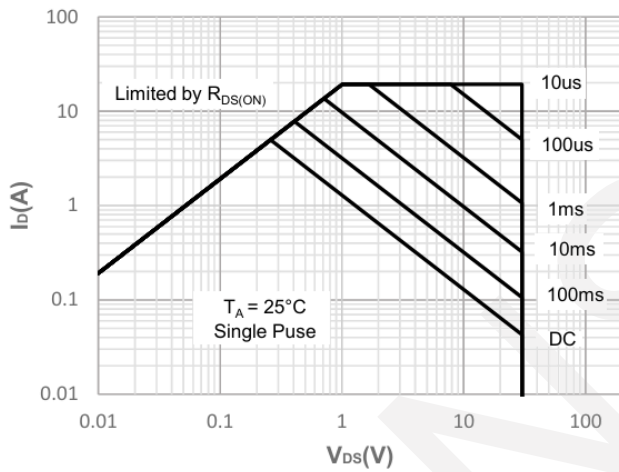
Capacitance Characteristics



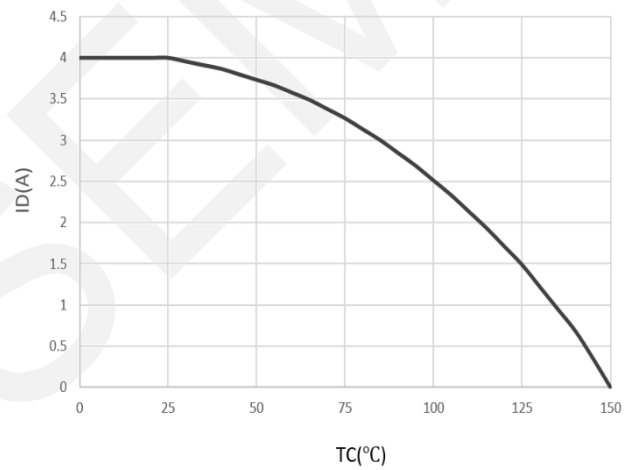
Normalized Breakdown voltage vs. Junction Temperature



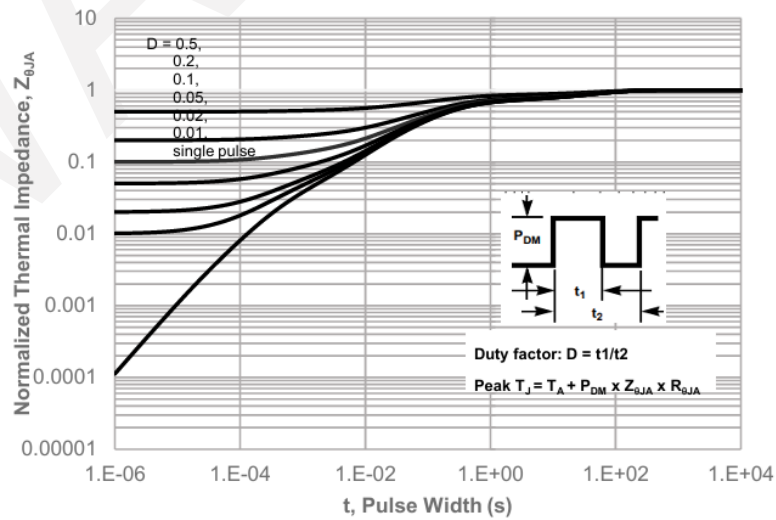
Normalized on Resistance vs. Junction Temperature



Maximum Safe Operating Area



Maximum Continuous Drain Current vs. Case Temperature



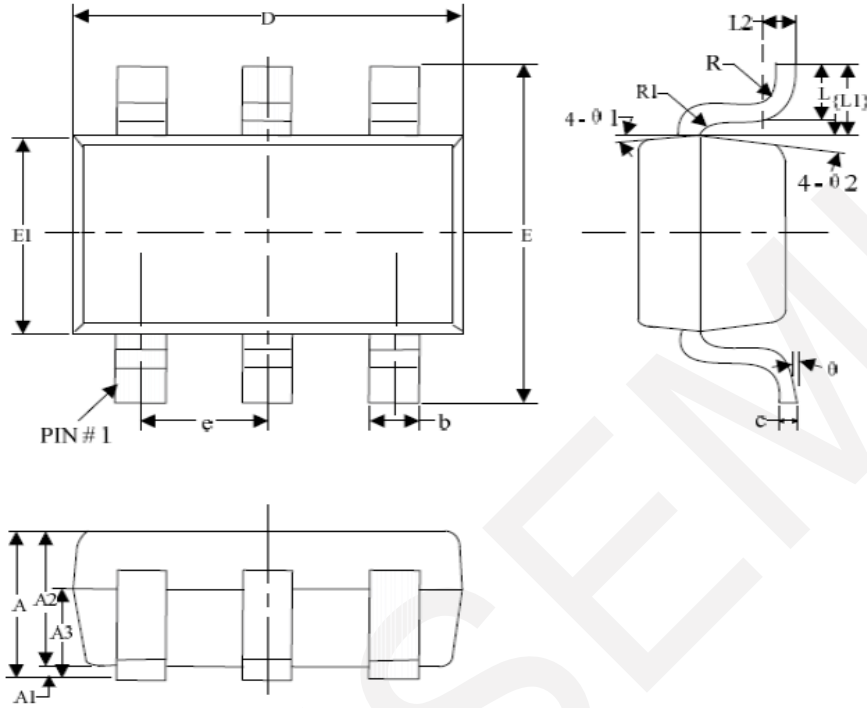
Maximum Effective Transient

Thermal Impedance, Junction-to-Case



7.Package Dimensions

SOT23-6



Dimensions (unit: mm)

SYMBOL	MIN	NOM	MAX	SYMBOL	MIN	NOM	MAX
A	-	-	1.30	e	0.85	0.95	1.05
A1	0	-	0.15	L	0.35	0.45	0.60
A2	0.90	1.10	1.30	L1	0.59REF		
A3	0.60	0.65	0.70	L2	0.25BSC		
b	0.39	-	0.49	R	0.05	-	-
c	0.12	-	0.19	R1	0.05	-	0.02
D	2.85	2.95	3.15	θ	0°	-	8°
E	2.60	2.80	3.00	θ_1	3°	5°	7°
E1	1.55	1.65	1.75	θ_2	6°	8°	10°

8.Important Notice

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